TOSHIBA Bi-CMOS Digital Integrated Circuit Silicon Monolithic

## **TENTATIVE**

# **TB2922HQ**

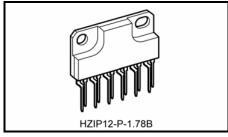
#### **Dual Audio Power Amplifier**

The TB2922HQ is 2ch BTL audio amplifier for TV or home audio applications.

It includes and the pure complementary P-ch and N-ch DMOS output stage.

The package is CPP (Compact Power Package).

It is built-in standby function, muting function various kinds of protectors.



Weight: 4.04 g (typ.)

#### **Features**

- · High power output
- :  $P_{OUT}(1) = 23 \text{ W (typ)}$ 
  - $(V_{CC} = 18V, R_L = 8 \Omega, f = 1 \text{ kHz}, THD = 10\%)$
- :  $P_{OUT}(2) = 39W (typ)$ 
  - $(V_{CC} = 16V, R_L = 4 \Omega, f = 1 \text{ kHz}, THD = 10\%)$
- :  $P_{OUT}(3) = 46W (typ)$ 
  - $(V_{CC} = 26V, R_L = 8 \Omega, f = 1 \text{ kHz}, THD = 10\%)$
- POUTMAX (1)= 72W (typ)
  - $(V_{CC} = 26V, R_L = 8 \Omega, f = 1 \text{ kHz}, Max Power)$
- Low distortion ratio : THD=0.02% (typ)
- Low noise  $V_{no} = 0.16 \mu \text{ Vrms (typ)}$

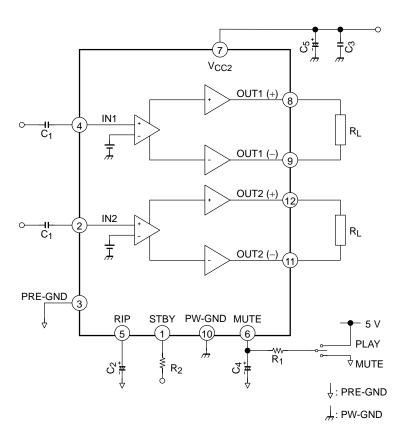
(V<sub>CC</sub> = 18V, R<sub>L</sub> = 8 
$$\Omega$$
, R<sub>g</sub> = 0  $\Omega$ , BW = 20 Hz~20 kHz)

- · Low outside parts
- Built-in standby switch function (pin 1)
- Built-in muting function (pin 6)
- Built-in various protection circuits:

Thermal shut down, overvoltage, out to GND, out to VCC, out to out short speaker burned

- Operating supply voltage
  - : V<sub>CC</sub> (opr) = 9 to 26 V (R<sub>L</sub> = 8  $\Omega$ )
  - : V<sub>CC</sub> (opr) = 9 to 18 V (R<sub>L</sub> = 4  $\Omega$ )

## **Block Diagram**



Note1: Some of the functional blocks, circuits, or constants in the block diagram may be omitted or simplified for explanatory purpose.

#### Caution and Application Method (Description is made only on the single channel)

#### 1. Voltage Gain Adjustment

This IC has no NF (negative feedback) Pins. Therefore, the voltage gain can not be adjusted, but it makes the device a space and total costs saver.

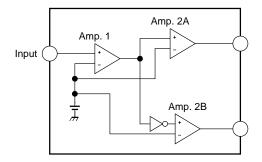


Figure 1 Block Diagram

The voltage gain of amp.1 :  $GV_1 = 8dB$ The voltage gain of amp.2A, B :  $GV_2 = 20dB$ The voltage gain of BTL connection: GV (BTL) = 6dB

Therefore, the total voltage gain is decided by expression below.

$$GV = GV_1 + GV_2 + GV (BTL) = 8 + 20 + 6 = 34dB$$

#### 2. Standby SW Function (pin 1)

By means of controlling pin 1 (standby pin) to High and Low, the power supply can be set to ON and OFF. The threshold voltage of pin 1 is set at about 3 VBE (typ.), and the power supply current is about 2  $\mu$ A (typ.) in the standby state.

#### Control Voltage of Pin 4: VSB

Stand-by	Power	V <sub>SB</sub> (V)		
ON	OFF	0 to 0.5		
OFF	ON	2.5 to 6 V		

When changing the time constant of pin 1, check the pop noise.

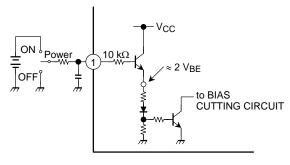


Figure 2 With pin 1 set to High, Power is turned ON

#### **Advantage of Standby SW**

- Since VCC can directly be controlled to ON or OFF by the microcomputer, the switching relay can be omitted.
- (2) Since the control current is microscopic, the switching relay of small current capacity is satisfactory for switching.

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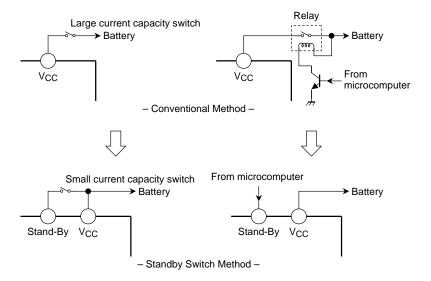


Figure 3

#### 3. Muting Function (pin 6)

Audio muting function is enabled when pin 6 is Low. When the time constant of the muting function is determined by R<sub>1</sub> and C<sub>4</sub>, it should take into account the pop noise. The pop noise, which is generated when the power or muting function is turned ON/OFF, will vary according to the time constant. (Refer to Figure 4)

The pin 6 is designed to operate off 5 V so that the outside pull-up resistor  $R_1$  is determined on the basic of this value:

ex) When control voltage is changed in to 6 V from 5 V.

$$6 \text{ V/5 V} \times 47 \text{ k} = 56 \text{ k}$$

Additionally, as the VCC is rapidly falling, the IC internal low voltage muting operates to eliminate the large pop noise basically.

The low voltage muting circuit pull 200  $\mu A$  current into the IC so that the effect of the internal low voltage muting does not become enough if the  $R_1$  is too small value.

To obtain enough operation of the internal low voltage muting, a series resistor,  $R_1$  at pin 6 should be  $47~\mathrm{k}\Omega$  or more.

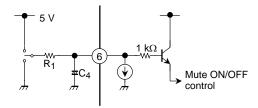


Figure 4 Muting Function

#### 4. Pop Noise Suppression

The pop noise which is generated when the muting function is turned ON/OFF will vary according to the time constant of C4.

The greater the capacitance, the lower the pop noise. Note that the time from when the mute control signal is applied to C4 to when the muting function is turned ON/OFF will be longer.

#### 5. External Component Constants

Component Recommended		Purpose	Effect		
Name Value	Lower than recommended value		Higher than recommended value		
C1	0.22 μF	To eliminate DC	Cut-off frequency is increased	Cut-off frequency is reduced	
C2	10 μF	To reduce ripple	Powering ON/OFF is faster	Powering ON/OFF takes longer	
C3	0.1 μF	To provide sufficient oscillation margin	Reduces noise and provides sufficient oscillation margin		
C4	1 μF	To reduce pop noise	High pop noise. Duration until muting function is turned ON/OFF is short	Low pop noise. Duration until muting function is turned ON/OFF is long	
C5	3900 μF	Ripple filter	Power supply ripple filtering		

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#### Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit	
DC supply voltage	V <sub>CC</sub> (DC)	28	V	
Operation supply voltage	tage V <sub>CC (opr)</sub> 26		V	
Power dissipation	P <sub>D</sub> (Note 2)	62.5	W	
Operation temperature	T <sub>opr</sub>	-40 to 85	°C	
Storage temperature	T <sub>stg</sub>	-55 to 150	°C	

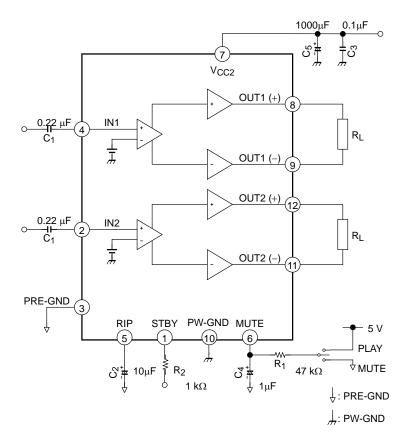
Note 2: Package thermal resistance  $\theta_{j-T} = 2^{\circ}C/W$  (typ.) (Ta = 25°C, with infinite heat sink)

The absolute maximum ratings of a semiconductor device are a set of specified parameter values, which must not be exceeded during operation, even for an instant. If any of these rating would be exceeded during operation, the device electrical characteristics may be irreparably altered and the reliability and lifetime of the device can no longer be guaranteed. Moreover, these operations with exceeded ratings may cause break down, damage and/or degradation to any other equipment. Applications using the device should be designed such that each maximum rating will never be exceeded in any operating conditions. Before using, creating and/or producing designs, refer to and comply with the precautions and conditions set forth in this documents.

# Electrical Characteristics (unless otherwise specified, $V_{CC}$ = 18 V, f = 1 kHz, $R_L$ = 8 $\Omega$ , Ta = 25°C)

Characteristics	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit
Quiescent current	Iccq	_	$V_{IN} = 0$	_	80	150	mA
Output power	P <sub>OUT</sub> (1)	_	THD = 10%	21	23	_	W
	P <sub>OUT</sub> (2)	_	THD = 10%, RL=4 $\Omega$	_	39	_	
	P <sub>OUT</sub> (3)	_	V <sub>CC</sub> = 26 V, THD = 10%	_	46	_	
	P <sub>OUT</sub> MAX (1)	_	V <sub>CC</sub> = 26V, Max POWER	_	72	_	
Total harmonic distortion	THD	_	P <sub>OUT</sub> = 4 W	_	0.03	0.2	%
Voltage gain	G <sub>V</sub>	_	V <sub>OUT</sub> = 0.775 Vrms	32	34	36	dB
Voltage gain ratio	ΔG <sub>V</sub>	_	V <sub>OUT</sub> = 0.775 Vrms	-1.0	0	1.0	dB
Output paige valtage	V <sub>NO</sub> (1)	_	Rg = $0 \Omega$ , DIN45405	_	160	_	μVrms
Output noise voltage	V <sub>NO</sub> (2)	_	Rg = 0 Ω, BW = 20 Hz~20 kHz	_	180	250	
Ripple rejection ratio	R.R.	_	$\begin{aligned} f_{rip} &= 100 \text{ Hz},  R_g = 620  \Omega \\ V_{rip} &= 0.775  \text{Vrms} \end{aligned}$	40	50	_	dB
Cross talk	C.T.	_	$\begin{array}{l} R_g = 620~\Omega \\ V_{OUT} = 0.775~\text{Vrms} \end{array}$	_	60	_	dB
Output offset voltage	VOFFSET	_	_	-250	0	250	mV
Input resistance	R <sub>IN</sub>	_	_	24	30	36	kΩ
Standby current	I <sub>SB</sub>	_	Standby condition	_	1	10	μΑ
Standby control voltage	V <sub>SB</sub> H	_	POWER: ON	2.5	_	6.0	- V
	V <sub>SB</sub> L	_	POWER: OFF	0	_	0.5	
Mute control voltage	V <sub>M</sub> H	_	MUTE: OFF	2.5	_	6.0	V
	V <sub>M</sub> L	_	MUTE: ON, $R_1 = 47 \text{ k}\Omega$	0	_	0.5	1 V
Mute attenuation	ATT M	_	MUTE: ON V <sub>OUT</sub> = 10 Vrms→Mute: OFF	85	100	_	dB

#### **Test Circuit**



Components in the test circuits are only used to obtain and confirm the device characteristics.

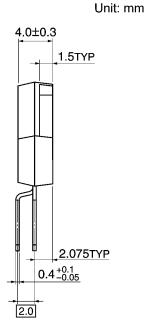
These components and circuits do not warrant to prevent the application equipment from malfunction or failure.

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## **Package Dimensions**

HZIP12-P-1.78B

15.72±0.2 Ø3.6±0.2 0.55±0.1 1.42TYP 1.778 1.1±0.1





Weight: 4.04 g (typ.)

About solderability, following conditions were confirmed

- Solderability
  - (1) Use of Sn-63Pb solder Bath
    - · solder bath temperature = 230°C
    - · dipping time = 5 seconds
    - · the number of times = once
    - · use of R-type flux
  - (2) Use of Sn-3.0Ag-0.5Cu solder Bath
    - solder bath temperature = 245°C
    - · dipping time = 5 seconds
    - · the number of times = once
    - · use of R-type flux

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